

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination HUYNH ET AL.	
		Examiner Michael Y. Won	Art Unit 2155	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,182,094	01-2001	Humbleman et al.	715/513
*	B	US-6,253,207	06-2001	Malek et al.	707/104.1
*	C	US-6,279,041	08-2001	Baber et al.	709/232
*	D	US-6,480,537	11-2002	Agrawal et al.	375/240
*	E	US-6,496,980	12-2002	Tillman et al.	725/90
*	F	US-6,738,803	05-2004	Dodrill et al.	709/218
*	G	US-6,760,916	07-2004	Holtz et al.	725/34
*	H	US-6,763,377	07-2004	Belknap et al.	709/223
*	I	US-6,976,082	12-2005	Ostermann et al.	709/231
*	J	US-6,992,983	01-2006	Chatterjee, Saurav	370/232
*	K	US-6,996,618	02-2006	Apostolopoulos et al.	709/227
*	L	US-7,003,794	02-2006	Arye, Ram	725/100
*	M	US-7,024,485	04-2006	Dunning et al.	709/232

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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